

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/607,982	LIU, YUE	
		Examiner	Art Unit	Page 1 of 1
		Bernard E Souw	2881	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,597,713	07-2003	Ouchi, Toshihiko	372/36
	B	US-2003/0127661 A1	07-2003	Takagi, Shinichi	257/98
	C	US-6,064,488	05-2000	Brand et al.	356/440
	D	US-2003/0015776 A1	01-2003	Recktenwald et al.	257/678
	E	US-6,661,084	12-2003	Peterson et al.	257/680
	F	US-6,594,050	07-2003	Jannson et al.	398/52
	G	US-2003/0026303	02-2003	OUCHI, TOSHIHIKO	372/36
	H	US-6,636,540	10-2003	Uebbing, John J	372/36
	I	US-2003/0081645 A1	05-2003	Uebbing, John J.	372/101
	J	US-2003/0137022 A1	07-2003	Dautartas et al.	257/432
	K	US-6,674,159	01-2004	Peterson et al.	257/680
	L	US-6,531,341	03-2003	Peterson et al.	438/123
	M	US-2002/0176468	11-2002	Kaneko, Takeo	372/50

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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